Di- μ -chloro-bis[chloro(η^5 -indenyl)methyl-hafnium(IV)]

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Abstract

The molecular structure of the title complex, $[HfCl(\mu-Cl)(CH_3)(\eta^5-C_9H_7)]_2$, which is a rare example of an indenylhafnium alkyl complex, is described. In this centrosymmetric structure, the geometry around each Hf atom is best described as a pseudo-square pyramid. There is a small amount of disorder between the methyl groups and the terminal chloride ligands.

Comment

The structural analysis of the title compound, (I), shows that it is composed of chloride-bridged dimers arranged in the $P2_1/n$ space group, and is structurally similar to $[HfCl_2(\mu-Cl)(\eta^5-C_9H_7)]_2$ (Shaw & Morris, 1995). The dimer possesses a crystallographically imposed inversion center, and the molecule consists of two edge-sharing distorted square pyramids. As is the case in virtually every η^5 -indenyl



(Ind) structure, the two bridgehead C atoms of (I) form longer bonds with the Hf center [mean Hf— $C_{bridgehead}$ distance = 2.519 (4) Å] than do the allyl-like C atoms [mean Hf— C_{allyl} distance = 2.454 (6) Å]. These Hf— $C_{indenyl}$ distances in (I) are similar to the Hf— C distances in [HfCl₂(μ -Cl)(η^5 -C₉H₇)]₂ [mean Hf— C_{bridgehead} distance = 2.526 (11) Å and mean Hf— C_{allyl} distance = 2.435 (11) Å], and show basically the same difference between Hf— C_{allyl} and Hf— $C_{bridgehead}$ distances. The Hf–centroid distance in (I) of 2.164 Å is slightly longer than that in [HfCl₂(μ -Cl)(η^5 -C₉H₇)]₂ of 2.154 Å. The terminal Hf—Cl distance of 2.398 (2) Å

for Hf—Cl distances in $[Cp*HfCl_2{Si(SiMe_3)_3}]$ and $[Cp*HfCl_2{Ge(SiMe_3)_3}]$ (Arnold *et al.*, 1988), but it is identical to the Hf-Cl distances of 2.391(6) and 2.394 (6) Å in isopropyl(cyclopentadienyl-1-fluorenyl)hafnium(IV) dichloride (Ewen et al., 1988). The Hf-Cl_{terminal} distance of 2.398 (2) Å is also slightly longer than that of the average of 2.382(4) Å for [HfCl₂(μ -Cl) $(\eta^5$ -C₉H₇)]₂, as are the Hf—Cl_{bridging} distances {mean Hf—Cl_{bridging} distance = 2.566 (2) Å in (I) versus 2.526 (11) Å in $[HfCl_2(\mu-Cl)(\eta^5-C_9H_7)]_2$. The bridging Hf-Cl distances in (I) of 2.565 (2) and 2.567 (2) Å represent symmetrical chloride bridges but, as expected, are longer than the terminal chloride distances. The Hf-C_{methyl} distance of 2.358(3) Å is similar to the $Hf - C_{methyl}$ distance in $Ind_2Hf(CH_3)_2$ [$Hf - C_{methyl} =$ 2.332 (12) Å; Atwood et al., 1975]. This increase is most likely a result of some disorder between the terminal Cl and the methyl C. The final occupancies are Cl3: 15.0(11)%C and 85.0(11)%Cl, and C4: 60.2(16)%C and 39.8(16)%Cl. Bond angles are as follows: Cl_{terminal}—Hf—C_{methyl} = 88.88 (9), Cl_{terminal}— $Hf-Cl_{bridging} = 83.33(6), cis-Cl_{bridging}-Hf-C_{methyl} =$ 82.64 (9), trans-Cl_{bridging}—Hf— $C_{methyl} = 135.90$ (9) and Cl_{bridging}—Hf—Cl_{bridging} = 75.54 (5)°. The indenyl plane [planar to within 0.046(11)Å] is canted, so that the allyl-like C atoms are closest to the plane defined by the bridging Cl and Hf atoms. However, the indenvl ring is nearly parallel to the plane defined by an Hf atom, a terminal Cl and a methyl C atom. There is an angle of $57.16(9)^{\circ}$ between the plane of the bridging Cl atoms and the plane of the terminal Cl and methyl C atoms.

is longer than the 2.337 (4)-2.354 (3) Å range reported



Fig. 1. Molecular structure diagram of (I) showing 35% probability displacement ellipsoids.

Experimental

The synthesis of (I) was carried out by the interaction of $[HfCl_2(\mu-Cl)(\eta^5-C_9H_7)]_2$ with trimethylaluminium-toluene for 24 h. Recrystallization was from toluene.

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Crystal data [Hf₂Cl₄(CH₃)₂(C₉H₇)₂] $M_r = 759.17$ Monoclinic $P2_1/n$ a = 7.7771 (12) Å b = 13.148 (2) Å c = 10.0967 (15) Å $\beta = 90.944 (9)^{\circ}$ $V = 1032.3 (3) Å^{3}$ Z = 2 $D_x = 2.442 \text{ Mg m}^{-3}$ $D_m \text{ not measured}$

Data collection

Refurbished Picker diffractometer $\theta/2\theta$ scans Absorption correction: analytical (de Meulenaer & Tompa, 1965) $T_{min} = 0.567, T_{max} = 0.743$ 3330 measured reflections 2366 independent reflections

Refinement

Refinement on F	$\Delta \rho_{\rm max} = 0.23 \ {\rm e} \ {\rm \AA}^{-3}$
R = 0.028	$\Delta \rho_{\rm min} = 0.20 \ {\rm e} \ {\rm \AA}^{-3}$
wR = 0.028	Extinction correction:
S = 1.259	Larson (1967)
2015 reflections	Extinction coefficient:
161 parameters	$0.5(3) \times 10^{-7}$
All H atoms refined	Scattering factors from Inter
$w = 1/[\sigma^2(F) + (0.04F)^2]$	national Tables for X-ray
$(\Delta/\sigma)_{\rm max} = 0.05$	Crystallography (Vol. IV)

Table 1. Selected geometric parameters (Å, °)

Hf1—Cl2	2.5649 (16)	Hf1C6	2.519 (6)
Hf1-C12 ⁱ	2.5668 (15)	Hf1—C7	2.453 (6)
Hf1Cl3	2.3977 (18)	Hf1-C9	2.450 (6)
Hfl—C4	2.358 (3)	Hf1-C10	2.519 (6)
Hf1—C5	2.459 (6)		
Cl2—Hf1—Cl2 ⁱ	75.54 (5)	Cl2'-Hf1-C4	135.90 (9)
Cl2—Hf1—Cl3	138.76 (6)	Cl3—Hf1—C4	88.88 (9)
Cl2 ⁱ —Hf1—Cl3	83.33 (6)	Hf1 ⁱ —Cl2—Hf1	104.46(5)
Cl2—Hf1—C4	82.64 (9)		

Symmetry code: (i) 1 - x, -y, 2 - z.

The structure was readily solved by direct methods (*MUL-TAN*78; Main *et al.*, 1978) and standard Fourier techniques. During refinement it was observed that some disorder is present between the terminal methyl and terminal chloride groups. The refinement results are: Cl3 = 15.0 (11)%C and 85.0 (11)%Cl, while C4 = 60.2 (16)%C and 39.8 (16)%Cl. Given that occupancy refinement is highly correlated with displacement parameters, the above may or may not indicate the presence of a small amount of $[HfCl_2(\mu-Cl)(\eta^5-C_9H_7)]_2$, in spite of the reported s.u.'s. H atoms were refined $[U_{iso} = 0.01 (2)-0.06 (2) Å^2]$ to yield C—H bond distances in the range 0.82 (15)-1.07 (12) Å.

Data collection: PCPS (local software). Cell refinement: XTEL (local software). Data reduction: XTEL. Program(s) used

$[Hf_2Cl_4(CH_3)_2(C_9H_7)_2]$

Mo $K\alpha$ radiation

 $\lambda = 0.71069$ Å Cell parameters from 56

reflections

 $\theta = 9.59 - 10.30^{\circ}$

 $\mu = 10.55 \text{ mm}^{-1}$

0.13 \times 0.13 \times 0.11 mm

2015 reflections with $F^2 > 2.33\sigma(F^2)$

4 standard reflections

every 400 reflections

intensity decay: -1.3%

 $R_{\rm int} = 0.025$

 $k = 0 \rightarrow 17$

 $\theta_{\rm max} = 27.5^{\circ}$ $h = -10 \rightarrow 3$

 $l = -13 \rightarrow 13$

T = 100 K

Needle

Orange

to solve structure: *SHELXTL/PC* (Sheldrick, 1990). Program(s) used to refine structure: *XTEL*. Molecular graphics: *XTEL*. Software used to prepare material for publication: *XTEL*.

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Supplementary data for this paper are available from the IUCr electronic archives (Reference: FR1091). Services for accessing these data are described at the back of the journal.

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2:1 Adducts of Halotris(*p*-tolyl)tin(IV) with 1,9-Bis(4-oxopent-2-en-2-ylamino)-3,7-dithianonane

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Abstract

The structures of $(\mu$ -5,15-diaza-8,12-dithianonadeca-3,16-diene-2,18-dione-O,O')bis[halotris(*p*-tolyl)tin] {halo is bromo, [Sn₂Br₂(C₇H₇)₆(C₁₇H₃₀N₂O₂S₂)], iodo, [Sn₂-